UNISONIC TECHNOLOGIES CO., LTD

UF840-F Power MOSFET

8.0A, 500V, 0.85Ω, N-CHANNEL POWER MOSFET

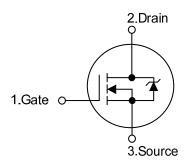
DESCRIPTION

The N-Channel enhancement mode silicon gate power MOSFET is designed for high voltage, high speed power switching applications such as switching regulators, switching converters, solenoid, motor drivers, relay drivers.

■ FEATURES

- * Low $R_{DS(ON)}$ < 0.87 Ω @ V_{GS} =10V. I_D = 4.4A
- * Single Pulse Avalanche Energy Rated
- * Fast Switching Speeds
- * Linear Transfer Characteristics
- * High Input Impedance

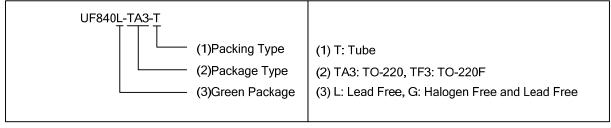
■ SYMBOL



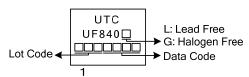
ORDERING INFORMATION

Ordering Number		Dookago	Pin Assignment			Packing	
Lead Free	Halogen Free	- Package	1	2	3	Facking	
UF840L-TA3-T	UF840G-TA3-T	TO-220	G	D	S	Tube	
UF840L-TF3-T	UF840G-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: A: Anode K: Cathode



■ MARKING



TO-220F

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UF840-F Power MOSFET

■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless Otherwise Specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain to Source Voltage		V_{DSS}	500	V
Drain to Gate Voltage		V_{DGR}	500	٧
Gate to Source Voltage		V_{GSS}	±30	V
Drain Current (Note 2)	Continuous	I_{D}	8.0	Α
	Pulsed	I_{DM}	32	Α
Avalanche Current (Note 2)		I _{AR}	9.4	Α
Single Pulse Avalanche Energy (Note 3)		E _{AS}	442	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.6	V/ns
Power Dissipation	TO-220	D	134	W
	TO-220F	P_D	44	W
Junction Temperature		T_J	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 10mH, I_{AS} = 9.4A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C.
- 4. $I_{SD} \le 8A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C.

■ THERMAL RESISTANCES CHARACTERISTICS

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
Junction to Case	TO-220	0	0.93	°C/W
	TO-220F	$\theta_{ m JC}$	2.84	°C/W

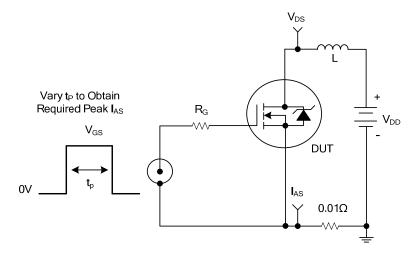
■ **ELECTRICAL CHARACTERISTICS** (T_J = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	500			V		
Drain-Source Leakage Current	I _{DSS}	V _{DS} =600V, V _{GS} =0V			25	μΑ		
Coto Source Leekage Current Forward	I _{GSS}	V_{GS} =30V, V_{DS} =0V			100	π Λ		
Gate-Source Leakage Current Reverse		V_{GS} =-30V, V_{DS} =0V			-100	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.0		4.0	V		
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4.4A			0.87	Ω		
DYNAMIC CHARACTERISTICS	_							
Input Capacitance	C _{ISS}			1480		pF		
Output Capacitance	Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		193		pF		
Reverse Transfer Capacitance	C _{RSS}			81		pF		
SWITCHING CHARACTERISTICS	_							
Total Gate Charge	Q_G	V _{DS} =50V, I _D =1.3A, V _{GS} =10V I _G =100μA (Note 1, 2)		120		nC		
Gate-Source Charge	Q_{GS}			7.0		nC		
Gate-Drain Charge	Q_{GD}	IG-100μA (Note 1, 2)		29		nC		
Turn-On Delay Time	t _{D(ON)}			54		ns		
Turn-On Rise Time	t _R	V_{DD} =30V, V_{GS} =10V, I_{D} =0.5A,		382		ns		
Turn-Off Delay Time	t _{D(OFF)}	R _G =25Ω (Note 1, 2)		165		ns		
Turn-Off Fall Time	t _F			210		ns		
DRAIN-SOURCE DIODE CHARACTERISTI	CS AND MAXI	MUM RATINGS						
Maximum Continuous Drain-Source Diode	Is				5	Α		
Forward Current	IS				3	^		
Maximum Pulsed Drain-Source Diode	I _{SM}				20	Α		
Forward Current	ISM				20	^		
Drain-Source Diode Forward Voltage	V_{SD}	I _S =5.0A, V _{GS} =0V			1.4	V		
Reverse Recovery Time (Note 1)	t _{rr}	I _S =5.0A, V _{GS} =0V,		320		nS		
Reverse Recovery Charge	Q _{rr}	dI _F /dt=100A/μs		3.55		μC		

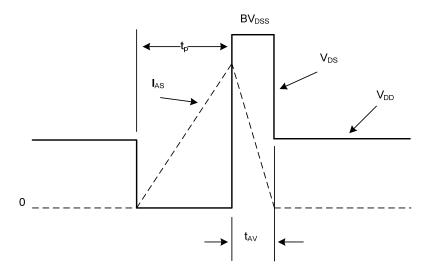
Note: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

^{2.} Essentially independent of operating temperature.

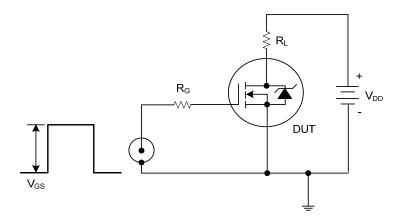
■ TEST CIRCUITS AND WAVEFORMS



Unclamped Energy Test Circuit



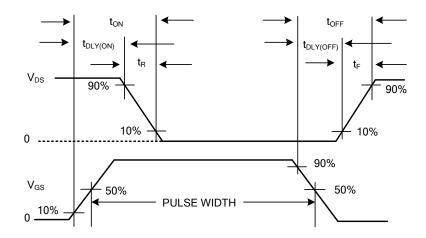
Unclamped Energy Waveforms



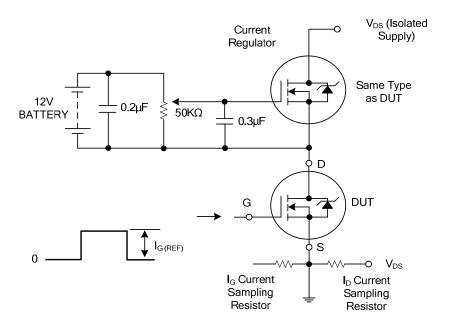
Switching Time Test Circuit

UF840-F

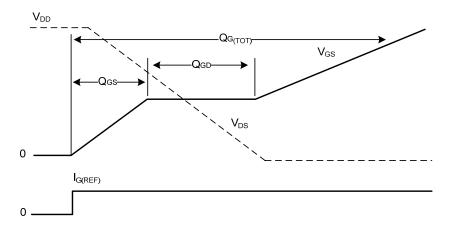
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



Resistive Switching Waveforms



Gate Charge Test Circuit



Gate Charge Waveforms

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